Sear	ch Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/765,623	YANIV ET AL.	
Examiner	Art Unit	
Mariceli Santiago	2879	

SEARCHED			
Class	Subclass	Date	Examiner
313	309, 495, 351	4/28/2005	WHY WHZ
445	24, 49-51	4/28/2005	Msz
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NO (INCLUDING SEARCH		·)
	DATE	EXMR
Parent application, refns checked	4/28/2005	Monz
attached copy search history	4/28/2005	Mysz
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